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T-227 P.004/014 F-233

**Practitioner's Docket No.: 796\_007**

**PATENT**

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re the Application of: **Takao OHNISHI, Toshikazu HIROTA and Shigeki KIRA**

Serial No.: 10/023,455

Group Art Unit: 1743

Filed: December 17, 2001

Examiner: Ludlow, Jan M.

Conf. No.: 2269

For: **METHOD OF FORMING DETECTION SPOTS ON AN ANALYTE DETECTION CHIP**

Mail Stop AF  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

**CERTIFICATE OF FACSIMILE TRANSMISSION**

I hereby certify that this paper is being facsimile transmitted to (571) 273-8300 in the Patent and Trademark Office on September 6, 2005.

*Janet M. Stevens*  
Janet M. Stevens

**AMENDMENT AFTER FINAL REJECTION**

Sir:

In response to the Office Action mailed May 5, 2005, please amend the above-identified application as follows:

Amendments to the Claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks/Arguments begin on page 8 of this paper.

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